Enter Amendment L.T.M.E. 1/13/2004

Attorney's Docket No. <u>015290-592</u> Application No. <u>10/075,602</u>

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## AMENDMENTS TO THE CLAIMS:

This listing of claims will replace all prior versions, and listings, of claims in the application:

## LISTING OF CLAIMS:

- 1-13. (Canceled)
- 14. (Previously presented) An oxygen-free plasma etching gas formulation for removing an organic ARC on a metallic layer comprising CHF<sub>3</sub>, argon and HCl or BCl<sub>3</sub>, the gas formulation being free of SF<sub>6</sub>.
- 15-17. (Canceled)
- 18. (Previously presented) An oxygen-free plasma etching gas formulation for removing an organic ARC on a metallic layer comprising CHF<sub>3</sub>, argon and chlorine, the gas formulation being free of SF<sub>6</sub>, and a ratio of flow rates of CHF<sub>3</sub>:argon:chlorine in the formulation is 5 to 80 sccm:5 to 80 sccm:5 to 60 sccm.
- 19-20. (Canceled)
- 21. (Previously presented) An oxygen-free plasma etching gas formulation for removing an organic ARC on a metallic layer comprising (i) more than one fluorine-containing compound, (ii) an inert carrier gas selected from the group consisting of krypton, argon, neon, helium, and mixtures thereof, and (iii) chlorine, the gas formulation being free of SF<sub>6</sub>.

22-27. (Canceled)

- 28. (Previously presented) The gas formulation of Claim 14, which comprises HCl.
- 29. (Previously presented) The gas formulation of Claim 14, which comprises BCl<sub>3</sub>.
- 30. (Previously presented) The gas formulation of Claim 21, wherein the inert carrier gas is krypton.
- 31. (Previously presented) The gas formulation of Claim 21, wherein the inert carrier gas is argon.
- 32. (Previously presented) The gas formulation of Claim 21, wherein the inert carrier gas is neon.
- 33. (Previously presented) The gas formulation of Claim 21, wherein the inert carrier gas is helium.
- 34. (Canceled)
- 35. (Canceled)